2016 Mass Resolution Re-Evaluation

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Re-Evaluate 2016 Mass Resolution

Due to a variety of simulation and reconstruction patches and updates.

Signal samples generated and reconstructed by Cam

Added to sample list for Pass4b on confluence Pass4b for 2016 MC

Applied momentum smearing with hpstr

Code in hpstr PR 187

Plotted and fit in notebook

Selecting vertices whose tracks have been strictly matched to truth-level "rad" electrons (i.e. not contaminated with recoil electrons)

Good Shape in Low Mass





- Both smeared and unsmeared histograms show normal behavior
- Normal distributions fit well
- Resulting resolution σ closest to previously estimated by Rafo

Starting to Distort





- Both smeared and unsmeared histograms show elongated low-side tail
 - Probably means issue with selection and not with smearing itself
- Resulting resolution σ deviating more from previous estimate





Figure 28: Mass distribution for 75 MeV A' MC. Left: unsmeared mass, right: smeared mass

Figure: From Rafo's 2016 Bump Hunt Internal Note end of Section 4.

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2016 Mass Resolution

Bad Shape at High Mass





- Both smeared and unsmeared histograms large low-side tails
 - Still an issue with selection
- Normal distributions not easily fitting peak
- Resulting resolution σ far from previous estimate

Summary





- Able to use newer generated samples to produce mass resolution estimates including track smearing
- Observing slight worsening in resolution (increase in σ) compared to previous estimate

Questions



- **Goal** : Center (mean μ) and Width (std dev σ) of peak
- Two stage process
- 1. Find Peak
- Iterative approach
 - 1. Calculate μ and σ from the bins
 - 2. Remove bins further than N\sigma away from μ
 - 3. Repeat until stable (i.e. no bins are being removed)
- For the results here, I chose N = 2.
- 2. Fit Normal Distribution
 - Actually fitting a "scaled" normal distribution which is just a normal distribution multiplied by some scale (basically ends up being the integral of the fit range if fit is good).
 - Only fitting to the range of bins selected in Stage 1 above.
 - Using uncertainty on bin content as errors of data points in fit.
 - $\blacksquare \ \mu$ and σ taken from this fit.